

TLP716

Plasma display panel

High Speed Interface

Factory Automation

The TOSHIBA TLP716 consists of a GaAlAs light emitting diode and a high speed photodetector. This unit is 6-lead SDIP. TLP716 is 50% smaller than 8PIN DIP and has suited the safety standard reinforced insulation class. So, mounting area in safety standard required equipment can be reduced.

- Inverter Logic (totempole output)
- Package Type : SDIP6
- Guaranteed Performance Over Temperature : $-40\sim 100^{\circ}\text{C}$
- Power Supply Voltage: 4.5~5.5 V
- Input Thresholds Current: $I_{FHL} = 6.5 \text{ mA (max)}$
- Propagation delay Time (t_{pHL}/t_{pLH}): 75 ns (max)
- Switching speed: 15 MBd (typ.) (NRZ)
- Common mode transient immunity: 10 kV/ μs (min)
- Isolation voltage: 5000 Vrms (min)
- UL Recognized: UL1577, File No.E67349
- Option (D4)
TÜV Approved : EN60747-5-2
Maximum Operating Insulation Voltage : 890 V_{PK}
Highest Permissible Over Voltage : 8000 V_{PK}
**(Note):When a EN60747-5-2 approved type is needed,
Please designate "Option(D4)"**

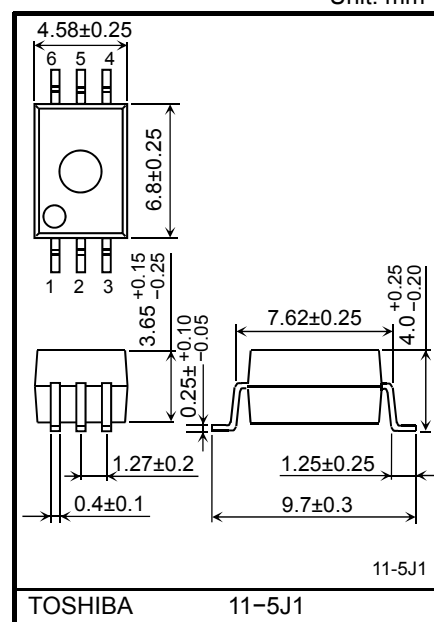
- Construction Mechanical Rating

	7.62 mm pitch standard type	10.16 mm pitch TLPXXXXF type
Creepage Distance	7.0 mm (min)	8.0 mm (min)
Clearance	7.0 mm (min)	8.0 mm (min)
Insulation Thickness	0.4 mm (min)	0.4 mm (min)

Truth Table

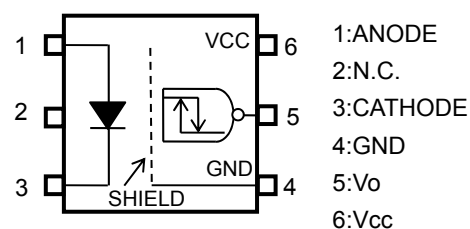
Input	LED	Tr1	Tr2	Output
H	ON	OFF	ON	L
L	OFF	ON	OFF	H

Unit: mm

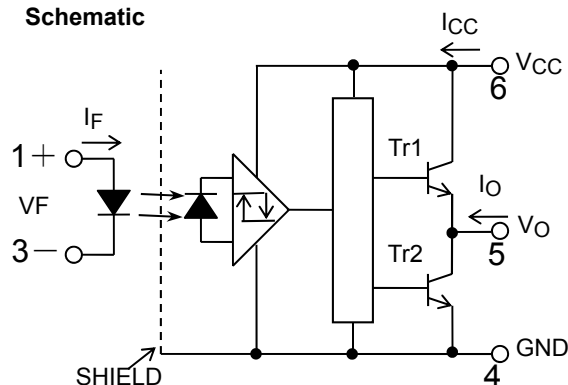


Weight : 0.26 g (typ.)

Pin Configuration (Top View)



Schematic



0.1 μF bypass capacitor must be connected between pins 6 and 4. (Note 4)

Start of commercial production
2006/06

Absolute Maximum Ratings (Ta=25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
LED	Forward Current (Ta ≤ 85°C)	I _F	20	mA
	Forward Current Derating (Ta > 85°C)	ΔI _F /ΔTa	-0.5	mA/°C
	Peak Transient Forward Current (Note1)	I _{FPT}	1	A
	Reverse Voltage	V _R	5	V
	Junction Temperature	T _j	125	°C
DETECTOR	Output Current (Ta ≤ 85°C)	I _O	10	mA
	Output Current Derating (Ta > 85°C)	ΔI _O /ΔTa	-0.25	mA/°C
	Output Voltage (Vo ≤ Vcc)	V _O	-0.5~6	V
	Supply Voltage	V _{CC}	-0.5~6	V
	Power Dissipation (Ta ≤ 85°C)	P _D	40	mW
	Power Dissipation Derating (Ta > 85°C)	ΔP _D /ΔTa	-1	mW/°C
	Junction Temperature	T _j	125	°C
Operating Temperature Range		Topr	-40~100	°C
Storage Temperature Range		Tstg	-55~125	°C
Lead Solder Temperature(10s)		Tsol	260	°C
Isolation Voltage (AC, 1 minute, R.H. ≤ 60%, Ta=25°C) (Note2)		BV _S	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Recommended Operating Conditions

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT
Input Current, ON	I _F (ON)	8	12	18	mA
Input Voltage, OFF	V _F (OFF)	0	—	0.8	V
Supply Voltage (*) (Note3, Note4)	V _{CC}	4.5	5	5.5	V

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

(*) This item denotes operating ranges, not meaning of recommended operating conditions.

The correlation between input current and switching speed and drive circuit (reference information)

Input Current (I_F)	TEST CIRCUIT	Typical Switching Speed
12mA	1 (Page 4)	14 – 16 MBd
8mA	1 (Page 4)	11 – 13 MBd
8mA	2 (Page 4, with Speed up capacitor)	16 – 20 MBd

Note 1: Pulse width $PW \leq 1\mu s$, 300pps.

Note 2: Device Considered a two terminal device: pins 1, 2 and 3 shorted together and pins 4, 5 and 6 shorted together.

Note 3: The detector of this product requires a power supply voltage (V_{CC}) of 4.5 V or higher for stable operation. If the V_{CC} is lower than this value, an I_{CC} may increase, or an output may be unstable. Be sure to use the product after checking the supply current, and the operation of a power-on/-off.

Note 4: A ceramic capacitor (0.1 μF) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

Electrical Characteristics

(Unless otherwise specified, $T_a = -40$ to $100^\circ C$, $V_{CC} = 4.5 \sim 5.5V$)

CHARACTERISTIC	SYMBOL	CONDITION	MIN	TYP. *	MAX	UNIT
Input Forward Voltage	V_F	$I_F = 10mA$, $T_a = 25^\circ C$	—	1.65	1.8	V
Temperature Coefficient of Forward Voltage	$\Delta V_F / \Delta T_a$	$I_F = 10mA$	—	-2.0	—	mV/ $^\circ C$
Input Reverse Current	I_R	$V_R = 5V$, $T_a = 25^\circ C$	—	—	10	μA
Input Capacitance	C_T	$V = 0V$, $f = 1MHz$, $T_a = 25^\circ C$	—	45	—	pF
Logic Low Output Voltage	V_{OL}	$I_{OL} = 1.6mA$, $I_F = 12mA$, $V_{CC} = 5V$	—	—	0.4	V
Logic High Output Voltage	V_{OH}	$I_{OH} = -0.02mA$, $V_F = 1.05V$, $V_{CC} = 5V$	4.0	—	—	V
Logic Low Supply Current	I_{CCL}	$I_F = 12mA$	—	—	5.0	mA
Logic High Supply Current	I_{CCH}	$V_F = 0V$	—	—	5.0	mA
Input Current Logic Low Output	I_{FHL}	$I_O = 1.6mA$, $V_O < 0.4V$	—	—	6.5	mA
Input Voltage Logic High Output	V_{FLH}	$I_O = -0.02mA$, $V_O > 4.0V$	0.8	—	—	V

*All typical values are at $T_a = 25^\circ C$, $V_{CC} = 5V$, $I_{F(ON)} = 12mA$ unless otherwise specified

Isolation Characteristics ($T_a = 25^\circ C$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Capacitance input to output	C_S	$V_S = 0V$, $f = 1MHz$ (Note 2)	—	0.8	—	pF
Isolation resistance	R_S	R.H. $\leq 60\%$, $V_S = 500V$ (Note 2)	1×10^{12}	10^{14}	—	Ω
Isolation voltage	BV_S	AC, 1 minute	5000	—	—	V_{rms}
		AC, 1 second, in oil	—	10000	—	
		DC, 1 minute, in oil	—	10000	—	Vdc

Switching Characteristics

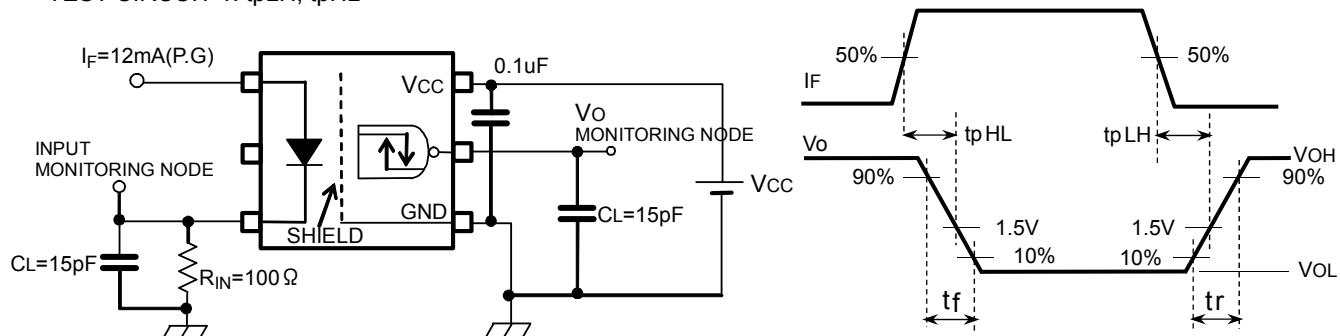
(Unless otherwise specified, $T_a = -40$ to 100°C , $V_{CC} = 4.5 \sim 5.5\text{V}$)

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION	MIN	TYP.	MAX	UNIT
propagation Delay Time to Logic Low output	t_{pHL}	1	$I_F = 0 \rightarrow 12\text{mA}$	—	—	75	ns
propagation Delay Time to Logic High output	t_{pLH}		$I_F = 12 \rightarrow 0\text{mA}$				
propagation Delay Time to Logic Low output	t_{pHL}	2	$V_{IN} = 0 \rightarrow 5\text{V}$ ($I_F = 0 \rightarrow 8\text{mA}$)	—	—	65	ns
propagation Delay Time to Logic High output	t_{pLH}		$V_{IN} = 5 \rightarrow 0\text{V}$ ($I_F = 8 \rightarrow 0\text{mA}$)				
Switching Time Dispersion between ON and OFF	$ t_{pLH} - t_{pHL} $	1	$I_F = 12\text{mA}$ $R_{IN} = 100\Omega$, $C_L = 15\text{pF}$ (Note 5)	—	—	45	ns
Output Fall Time (90 ~ 10%)	t_f		$I_F = 0 \rightarrow 12\text{mA}$	—	15	—	ns
Output Rise Time (10 ~ 90%)	t_r		$I_F = 12 \rightarrow 0\text{mA}$	—	15	—	ns
Common Mode transient Immunity at High Level Output	CM_H	3	$V_{CM} = 1000\text{Vp-p}$, $I_F = 0\text{mA}$, $V_{O(\text{Min})} = 4\text{V}$, $T_a = 25^\circ\text{C}$	10000	—	—	$\text{V}/\mu\text{s}$
Common Mode transient Immunity at Low Level Output	CM_L		$V_{CM} = 1000\text{Vp-p}$, $I_F = 12\text{mA}$, $V_{O(\text{Max})} = 0.4\text{V}$, $T_a = 25^\circ\text{C}$	-10000	—	—	$\text{V}/\mu\text{s}$

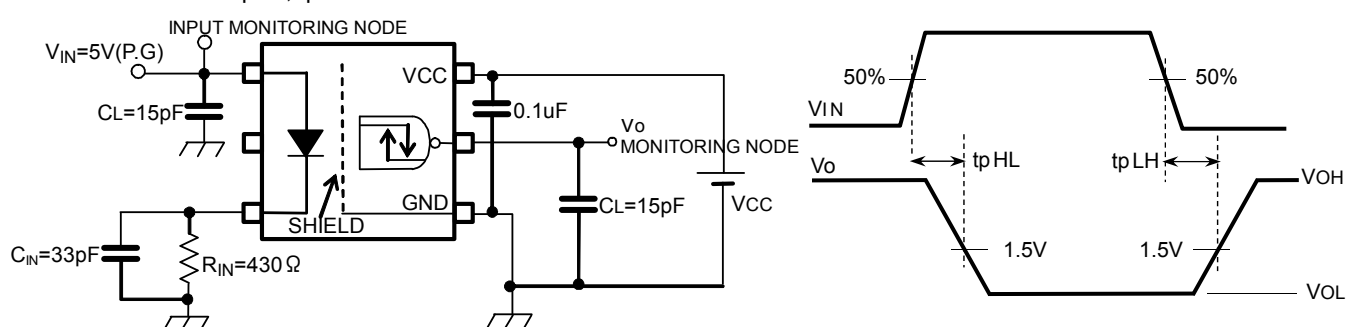
*All typical values are at $T_a = 25^\circ\text{C}$

Note 5: C_L is approximately 15pF which includes probe and jig/stray wiring capacitance.

TEST CIRCUIT 1: t_{pLH} , t_{pHL}



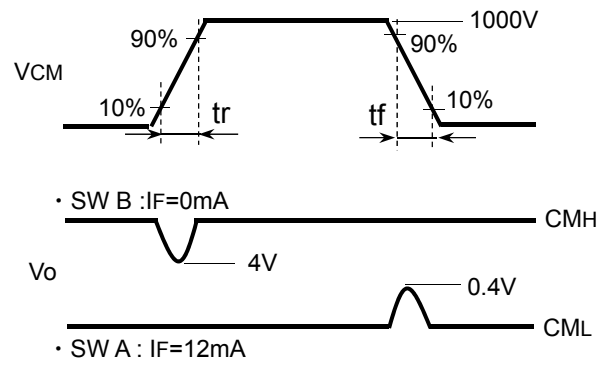
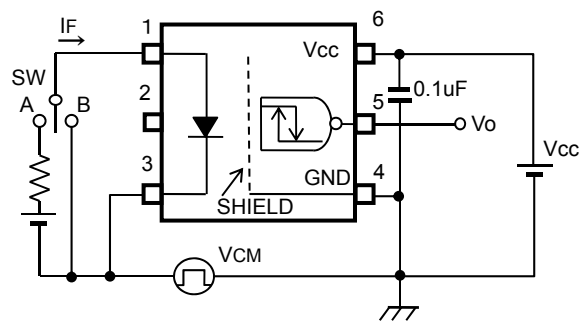
TEST CIRCUIT 2: t_{pLH} , t_{pHL}



The PROBE and JIG capacitances are included in C_L .

(P.G) : Pulse Generator

TEST CIRCUIT 3: Common-Mode Transient Immunity Test Circuit



$$CMH = \frac{800(V)}{tr(\mu s)}$$

$$CML = -\frac{800(V)}{tf(\mu s)}$$

CM_L (CM_H) is the maximum rate of fall (rise) of the common mode voltage that can be sustained with the output voltage in the low (high) state.

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